Form PTO-1449

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

Docket Number (Optional) 4373.2US (00-0036.02/US)	Application Number Not Yet Assigned
Applicant Chopra et al.	
Filing Date July 14, 2003	Group Art Unit Unknown

	IN AN APPL	ICATION						
(Use several sheets if necessary)			Filing Date July 14, 2003 Group Art Unit Unknown				wn .	
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L.T.M-E	DOCUMENT NUMBER WO 98/49723	R DATE				SUBCLASS		
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Lynotte J. Ume-Tunini 3/1/2005

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PTO/SB/08A (10-01)

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Substitute	Botom 1449A/PTO	7			Complete if Known
INFO	RMATION	DIS	CLOSURE	Application Number	10/620,002
STATEMENT BY APPLICANT			•	Filing Date	July 14, 2003
		First Named Inventor	Chopra et. al.		
_				Group Art Unit	3723
(use as many sheets as necessary)			ecessary)	Examiner Name	unknown
Sheet	1	of	1	Attorney Docket Number	2269-4373.2US (00-0036.02/US)

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Examiner Signature	Lynette	J. Umer E	Date Cons	idered 3	11/2005

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